Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination | ler |
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| 10/706,757 | CHOU ET AL. | |
| Examiner | Art Unit | _ |
| Binh X. Tran | 1765 | |

| | SEAR | CHED | |
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| Class | Subclass | Date | Examiner |
| 216 | 44 | 3/3/2006 | ВТ |
| 216 | 53 | 3/3/2006 | ВТ |
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| SEARCH NOT (INCLUDING SEARCH | |) |
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| | DATE | EXMR |
| Search keywords and inventor's name using USPAT, USPG-PUB, JPO, EPO, DERWENT database | 3/3/2006 | вт |
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